

Search Notes

Application/Control No.

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Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

BISHER ET AL.

Art Unit

2623

SEARCHED

Class	Subclass	Date	Examiner
725	111-119	5/31/2006	A.S

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR